CCB021M12FM3

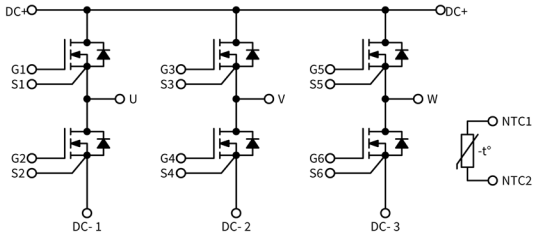
1200 V, 21 mΩ All-Silicon Carbide Six-Pack Module

V_{DS}	1200 V
$R_{DS(on)}$	21 mΩ

Technical Features

- Ultra-Low Loss
- High Frequency Operation
- Zero Turn-Off Tail Current from MOSFET
- Normally-Off, Fail-Safe Device Operation

Package



Applications

- EV Chargers
- Solar
- High-Efficiency Converters / Inverters
- Motor & Traction Drives
- Smart-Grid / Grid-Tied Distributed Generation

System Benefits

- Enables Compact, Lightweight Systems
- Increased System Efficiency due to Low Switching & Conduction Losses of SiC
- Reduced Thermal Requirements and System Cost

Maximum Parameters (Verified by Design)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{DS\,max}$	Drain-Source Voltage			1200	V		
$V_{GS\,max}$	Gate-Source Voltage, Maximum Value	-8		+19		Transient, <100 ns	Fig. 33
$V_{GS\,op}$	Gate-Source Voltage, Recommended Op. Value	-4		+15		Static	
I_D	DC Continuous Drain Current ($T_{VJ} \leq 150$ °C)		51		A	V_{GS} = 15 V, T_H = 50 °C, $T_{VJ} \leq 150$ °C	Fig. 20 Note 1
	DC Continuous Drain Current ($T_{VJ} \leq 175$ °C)		53			V_{GS} = 15 V, T_H = 50 °C, $T_{VJ} \leq 175$ °C	
$I_{SD\,BD}$	DC Source-Drain Current (Body Diode)		23			V_{GS} = - 4 V, T_H = 50 °C, $T_{VJ} \leq 175$ °C	
$I_{D\,(pulsed)}$	Maximum Pulsed Drain Current			106		t_{Pmax} limited by T_{jmax} V_{GS} = 15 V, T_H = 50 °C	
$T_{VJ\,op}$	Maximum Virtual Junction Temperature under Switching Conditions	-40		150	°C	Operation	
		-40		175	°C	Intermittent with Reduced Life	

Note 1. DC continuous drain current rating, I_D, limited to 30 A by the press-fit pins.

MOSFET Characteristics (Per Position) (T_{VJ} = 25 °C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	V_{GS} = 0 V, T_{VJ} = -40 °C	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.5	3.6		V_{DS} = V_{GS}, I_D = 17.7 mA	
I_{DSS}	Zero Gate Voltage Drain Current		1	25	µA	V_{GS} = 0 V, V_{DS} = 1200 V	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	V_{GS} = 15 V, V_{DS} = 0 V	
$R_{DS(on)}$	Drain-Source On-State Resistance (Devices Only)		21.0	27.9	mΩ	V_{GS} = 15 V, I_D = 30 A	Fig. 2 Fig. 3
			32.6			V_{GS} = 15 V, I_D = 30 A, T_{VJ} = 150 °C	
			38.0			V_{GS} = 15 V, I_D = 30 A, T_{VJ} = 175 °C	
g_{fs}	Transconductance		26.1		S	V_{DS}= 20 V, I_{DS}= 30 A	Fig. 4
			25.9			V_{DS}= 20 V, I_{DS}= 30 A, T_{VJ} = 150 °C	
E_{On}	Turn-On Switching Energy, T_J = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C		0.50 0.55 0.62		mJ	V_{DS} = 600 V, I_D = 30 A, V_{GS} = -4 V/15 V, $R_{G(OFF)}$ = 0.0 Ω, $R_{G(ON)}$ = 0.0 Ω L= 45.1 µH	Fig. 11 Fig. 13
E_{Off}	Turn-Off Switching Energy, T_J = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C		0.020 0.035 0.044				
$R_{G(int)}$	Internal Gate Resistance		3.3		Ω	T_{VJ} = 25 °C, f = 100 kHz, V_{AC} = 25 mV	
C_{iss}	Input Capacitance		4.9		nF	V_{GS} = 0 V, V_{DS} = 800 V, V_{AC} = 25 mV, f = 100 kHz	Fig. 9
C_{oss}	Output Capacitance		209		pF		
C_{rss}	Reverse Transfer Capacitance		16				
Q_{GS}	Gate to Source Charge		49		nC	V_{DS} = 800 V, V_{GS} = -4 V/15 V I_D = 40 A Per IEC60747-8-4 pg 21	
Q_{GD}	Gate to Drain Charge		50				
Q_G	Total Gate Charge		162				
$R_{th\ JH}$	FET Thermal Resistance, Junction to Heatsink		1.16		°C/W		Fig. 17

Diode Characteristics (Per Position) (T_{VJ} = 25 ˚C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Body Diode Forward Voltage		5.3		V	V_{GS} = -4 V, I_{SD} = 30 A	Fig. 7
			4.8			V_{GS} = -4 V, I_{SD} = 30 A, T_{VJ} = 150 °C	
t_{rr}	Reverse Recovery Time		16		ns	V_{GS} = -4 V, I_{SD} = 30 A, V_R = 600 V di/dt = 16 A/ns, $R_{G(ON)}$ = 0.0 Ω, T_J = 150 °C	Fig. 32
Q_{RR}	Reverse Recovery Charge		1.3		µC		
I_{RRM}	Peak Reverse Recovery Current		135		A		
E_{RR}	Reverse Recovery Energy T_J = 25 °C T_J = 125 °C T_J = 150 °C		0.14 0.20 0.25		mJ	V_{DS} = 600 V, I_D = 30 A, V_{GS} = -4 V/15 V, $R_{G(ON)}$ = 0.0 Ω, L= 45.1 µH	Fig. 14

Module Physical Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
R_{HS}	Package Resistance, M1, M3, M5 (High-Side)		5.3		mΩ	T_C = 25 °C, I_D = 30 A, Note 2
			5.9			T_C = 125 °C, I_D = 30 A, Note 2
R_{LS}	Package Resistance, M2, M4, M6 (Low-Side)		7.4			T_C = 25 °C, I_D = 30 A, Note 2
			8.1			T_C = 125 °C, I_D = 30 A, Note 2
L_{Stray}	Stray Inductance		17.4		nH	Between Terminals DC+ and DC-
T_C	Case Temperature	-40		125	°C	
W	Weight		21		g	
M_S	Mounting Torque		2.0	2.3	N-m	M4 bolts
V_{isol}	Case Isolation Voltage		3		kV	AC, 50 Hz, 1 min
CTI	Comparative Tracking Index	200				
	Clearance Distance		5.0		mm	Terminal to Terminal
			10.0			Terminal to Heatsink
	Creepage Distance		6.3			Terminal to Terminal
			11.5			Terminal to Heatsink

Note 2. Total Effective Resistance (Per Switch Position) = MOSFET $R_{DS(on)}$ + Switch Position Package Resistance.

NTC Thermistor Characterization

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
R_{NTC}	Rated Resistance		5.0		kΩ	T_{NTC} = 25 °C	Fig. 23
ΔR/R	Resistance Tolerance at 25°C	-5		5	%		
$\beta_{25/50}$	Beta Value (T_2 = 50°C)		3380		K		
$\beta_{25/80}$	Beta Value (T_2 = 80°C)		3468		K		
$\beta_{25/100}$	Beta Value (T_2 = 100°C)		3523		K		
P_{Max}	Power Dissipation			10	mW	T_{NTC} = 25 °C	

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Typical Performance

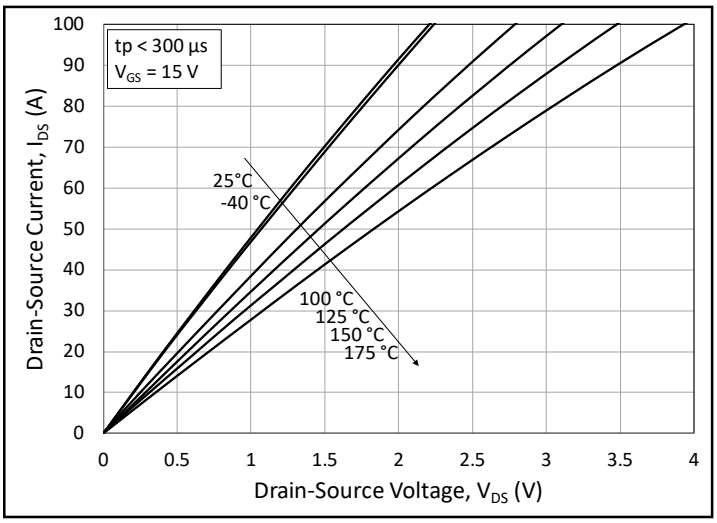

Figure 1. Output Characteristics for Various Junction Temperatures

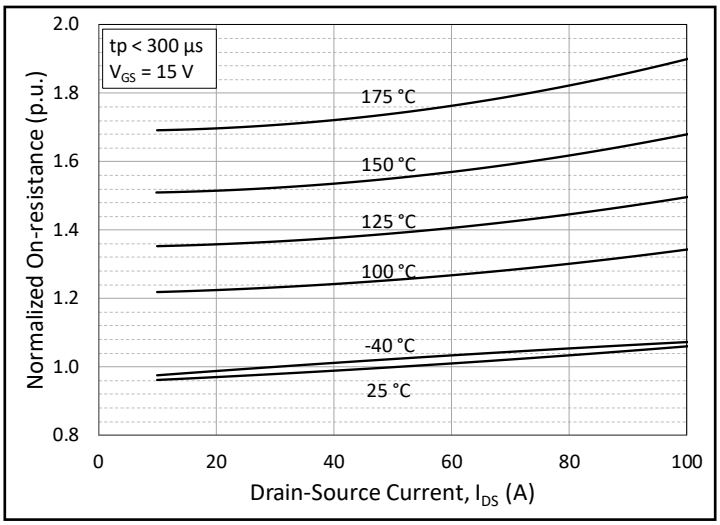

Figure 2. Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures

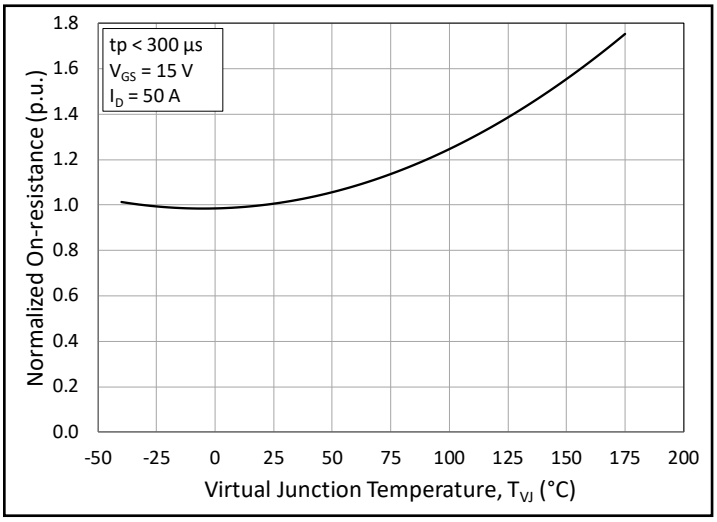

Figure 3. Normalized On-State Resistance vs. Junction Temperature

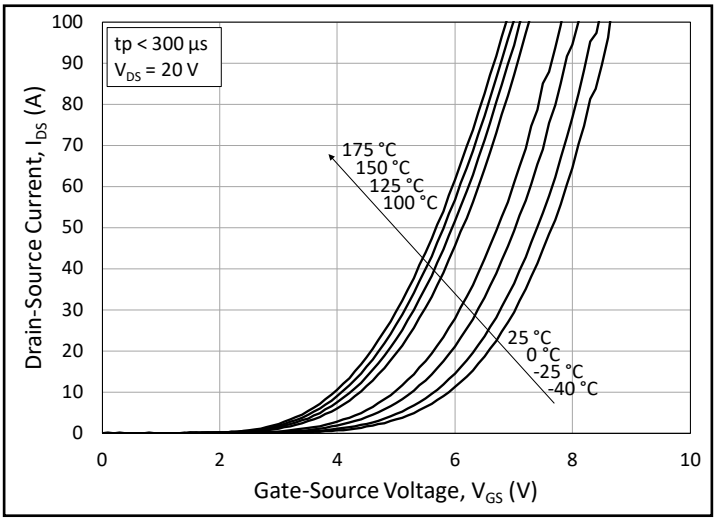

Figure 4. Transfer Characteristic for Various Junction Temperatures

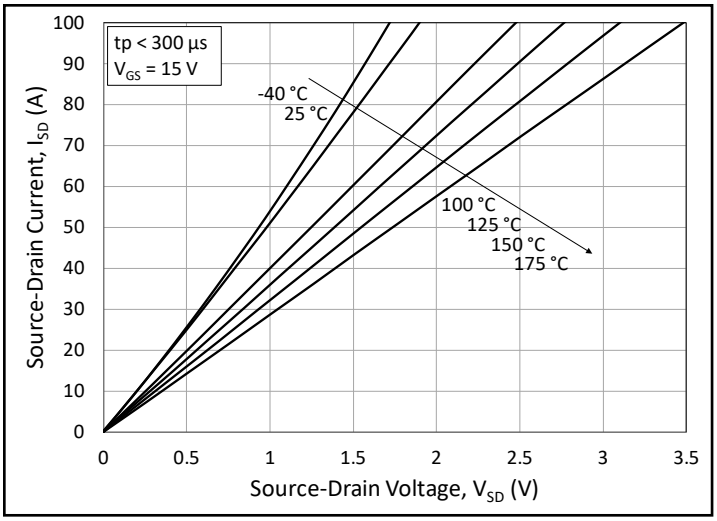

Figure 5. 3rd Quadrant Characteristic vs. Junction Temperatures at V_{GS} = 15 V

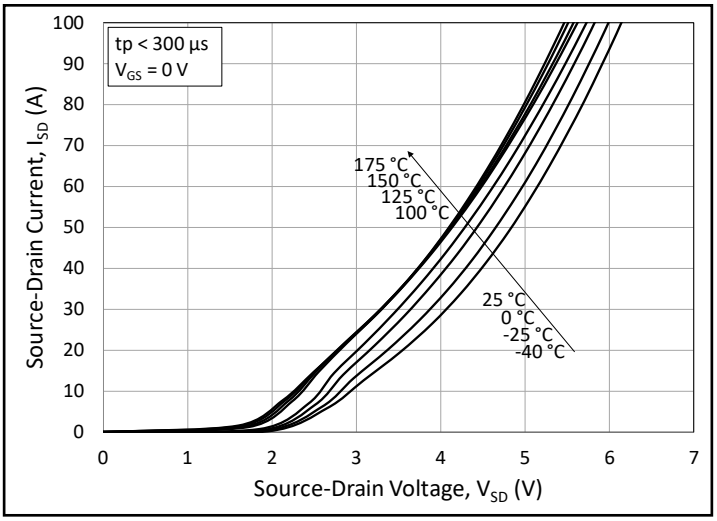

Figure 6. 3rd Quadrant Characteristic vs. Junction Temperatures at V_{GS} = 0 V (Body Diode)

Typical Performance

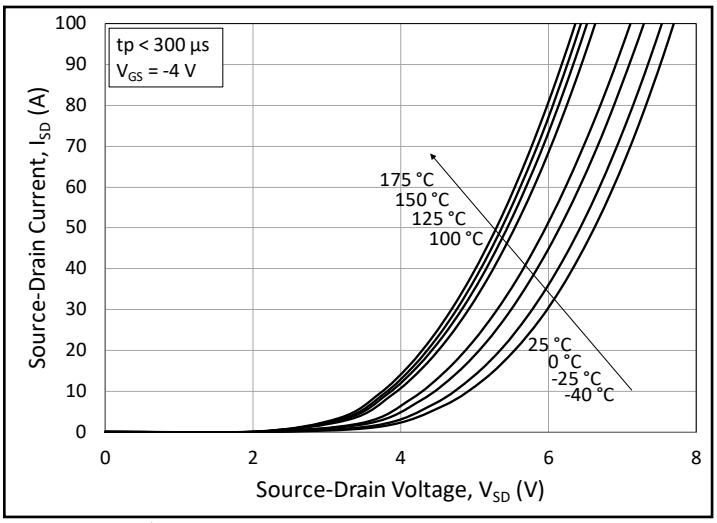

Figure 7. 3rd Quadrant Characteristic vs. Junction Temperatures at V_{GS} = - 4 V (Body Diode)

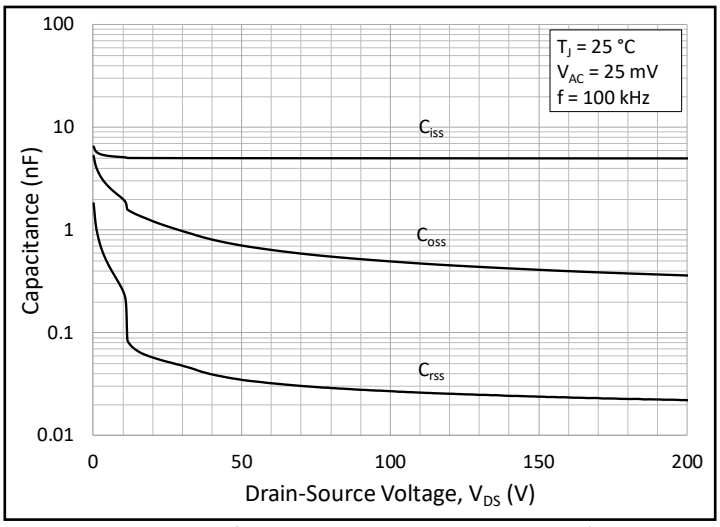

Figure 8. Typical Capacitances vs. Drain to Source Voltage (0 - 200V)

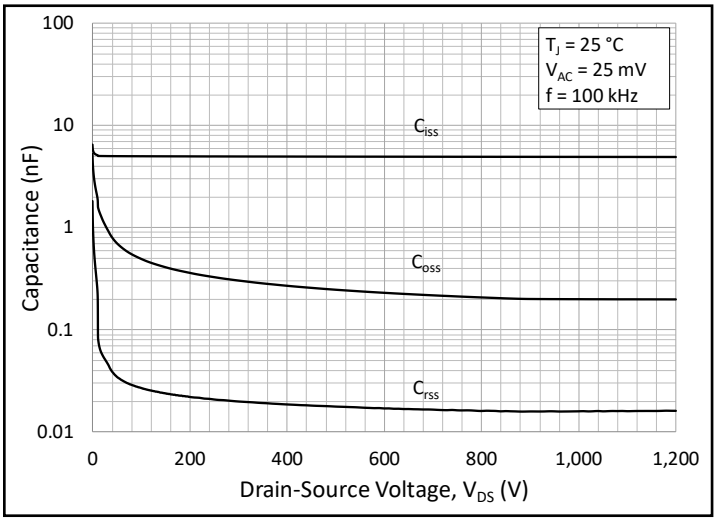

Figure 9. Typical Capacitances vs. Drain to Source Voltage (0 - 1200V)

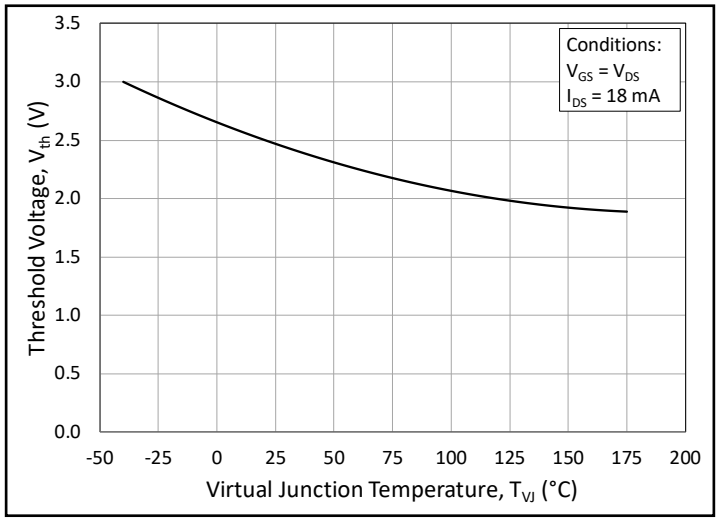

Figure 10. Threshold Voltage vs. Junction Temperature

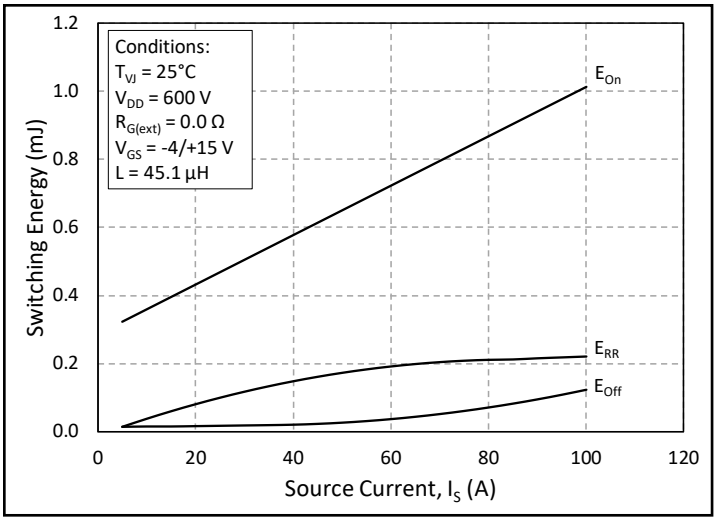

Figure 11. Switching Energy vs. Drain Current (V_{DS} = 600 V)

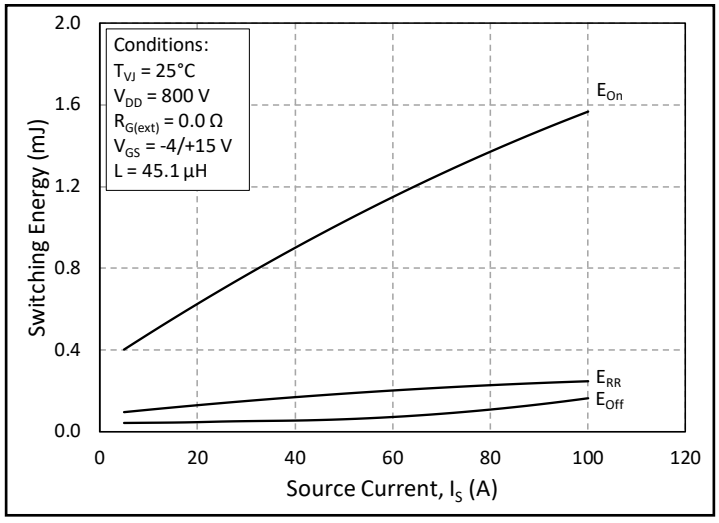

Figure 12. Switching Energy vs. Drain Current (V_{DS} = 800 V)

Typical Performance

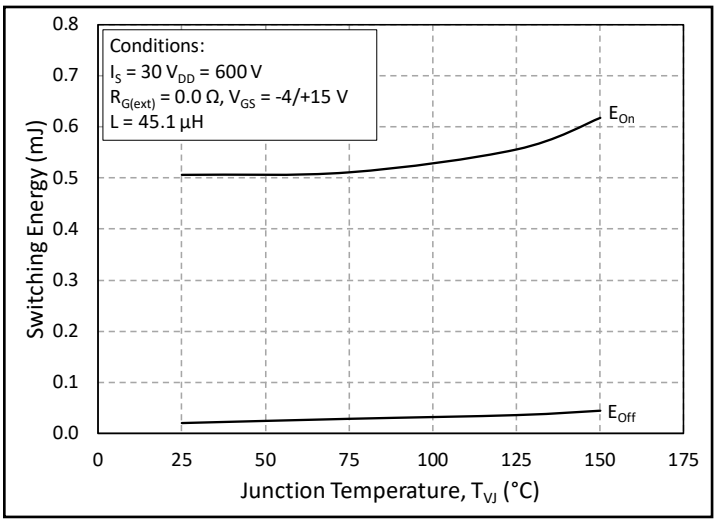

Figure 13. MOSFET Switching Energy vs. Junction Temperature

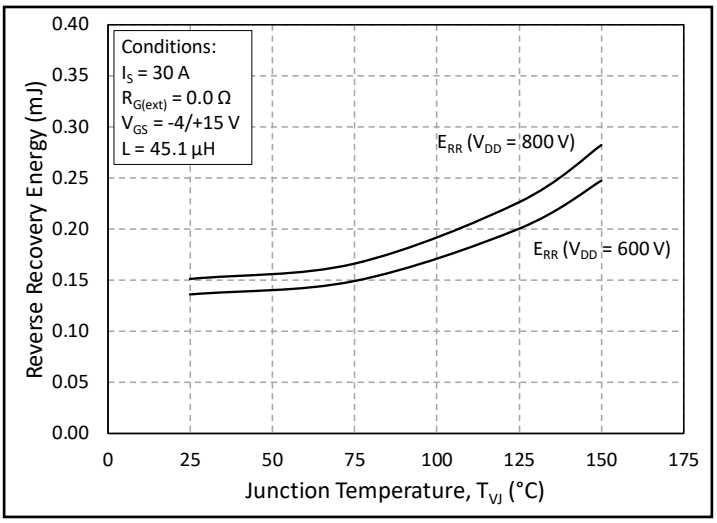

Figure 14. Reverse Recovery Energy vs. Junction Temperature

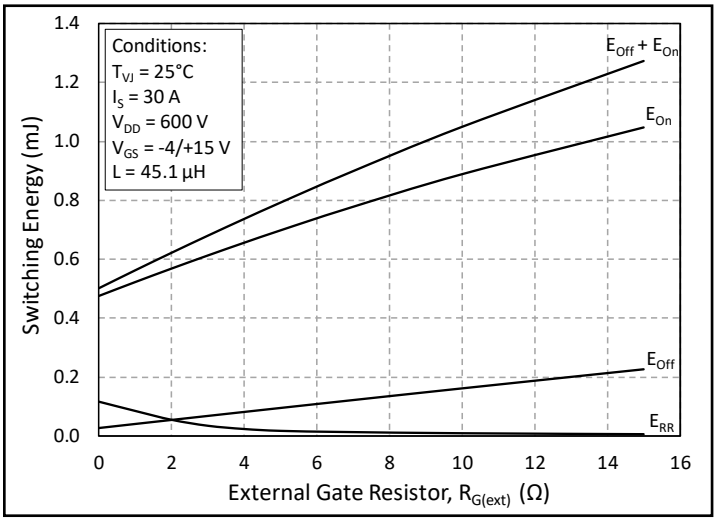

Figure 15. MOSFET Switching Energy vs. External Gate Resistance

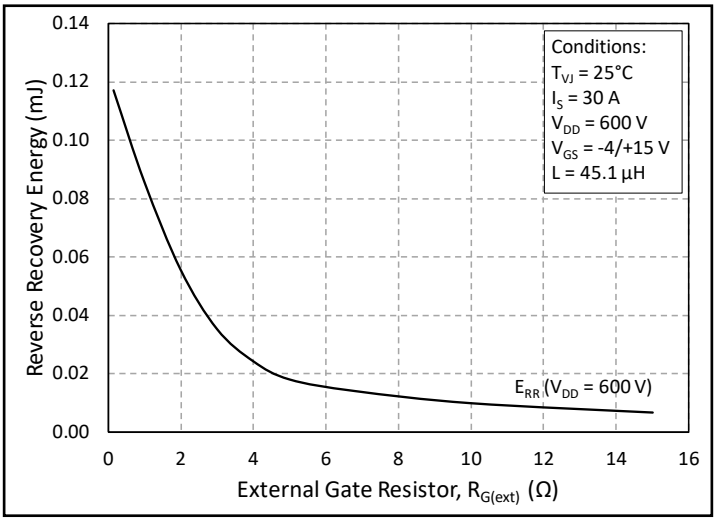

Figure 16. Reserve Recovery Energy vs. External Gate Resistance

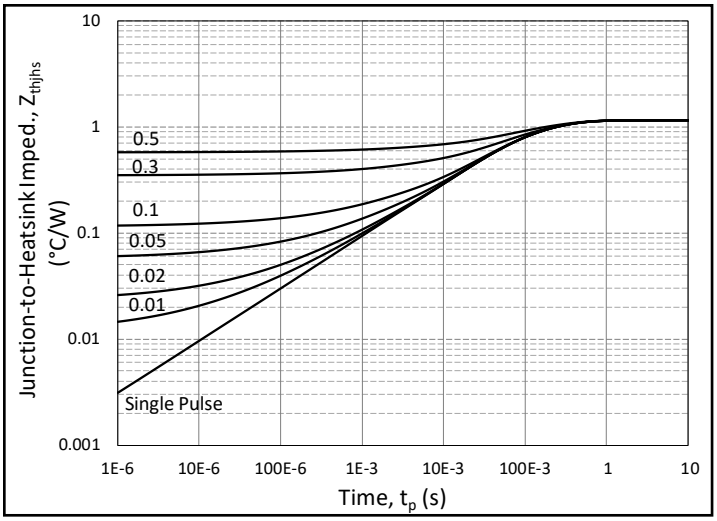

Figure 17. MOSFET Junction to Case Transient Thermal Impedance, $Z_{th\ JC}$ (°C/W)

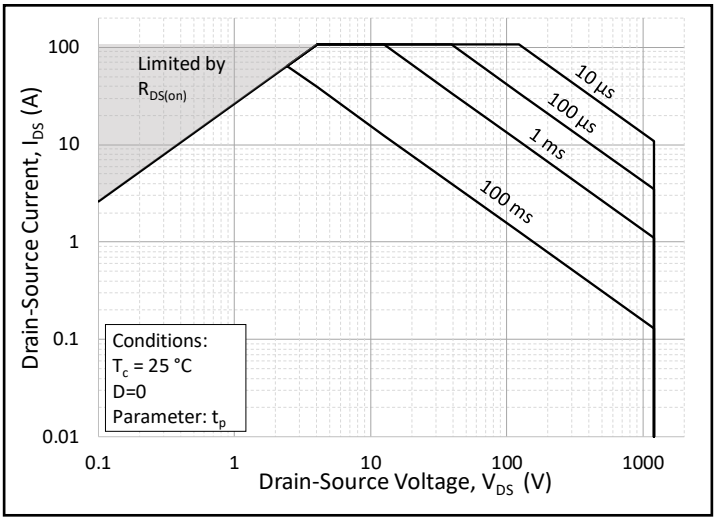

Figure 18. Forward Bias Safe Operating Area (FBSOA)

Typical Performance

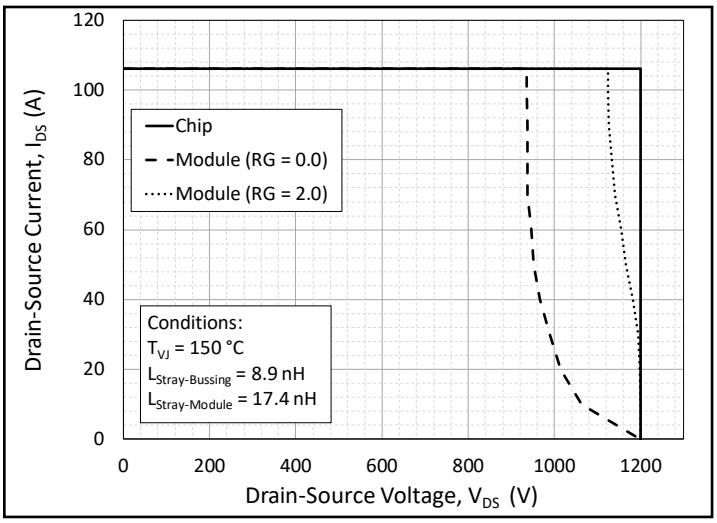

Figure 19. Reverse Bias Safe Operating Area (RBSOA)

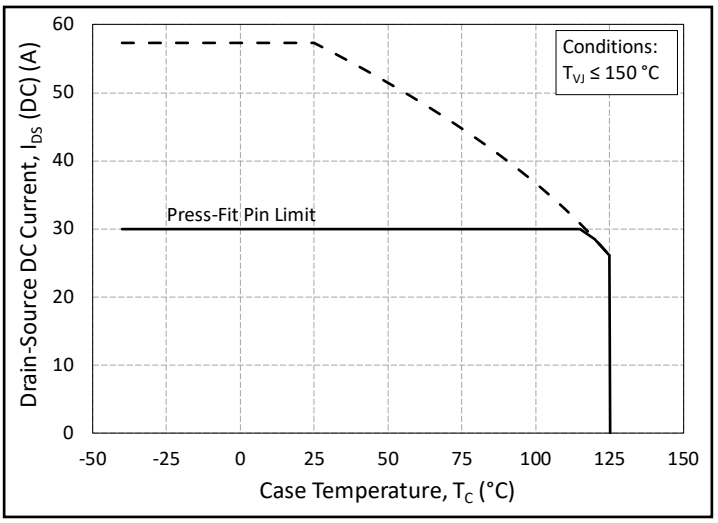

Figure 20. Continuous Drain Current Derating vs. Case Temperature

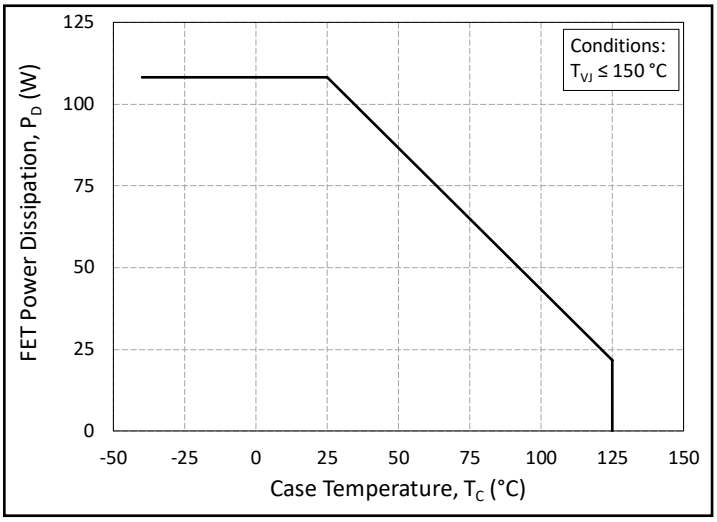

Figure 21. Maximum Power Dissipation Derating vs. Case Temperature

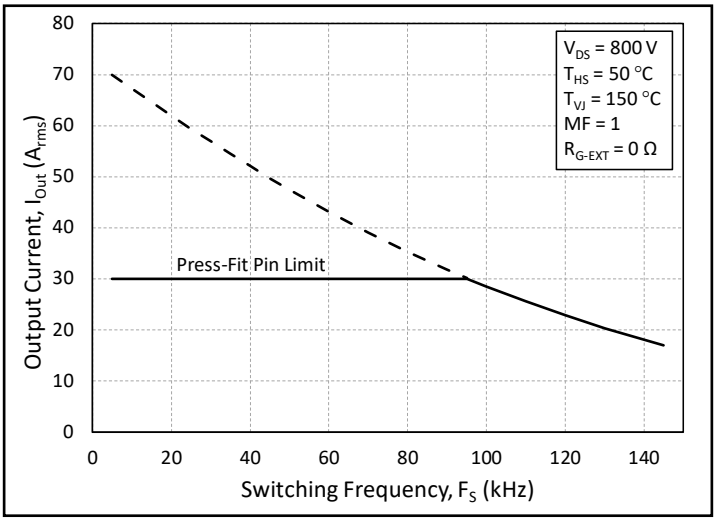

Figure 22. Typical Output Current Capability vs. Switching Frequency (Inverter Application)

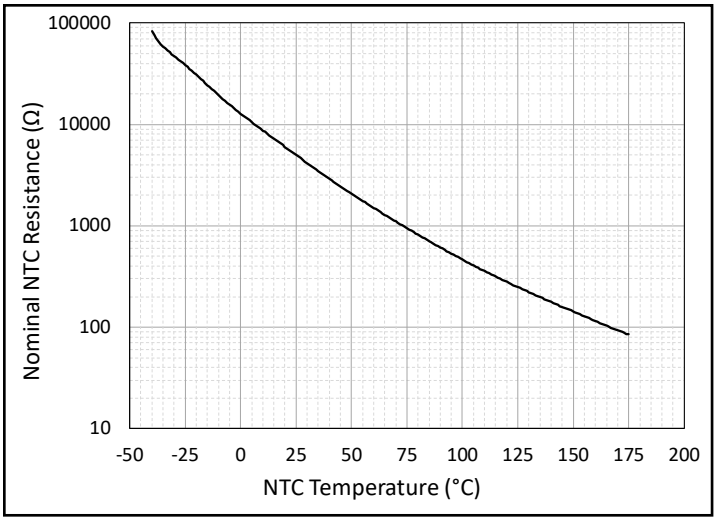

Figure 23. Nominal NTC Resistance vs. NTC Temperature

Timing Characteristics

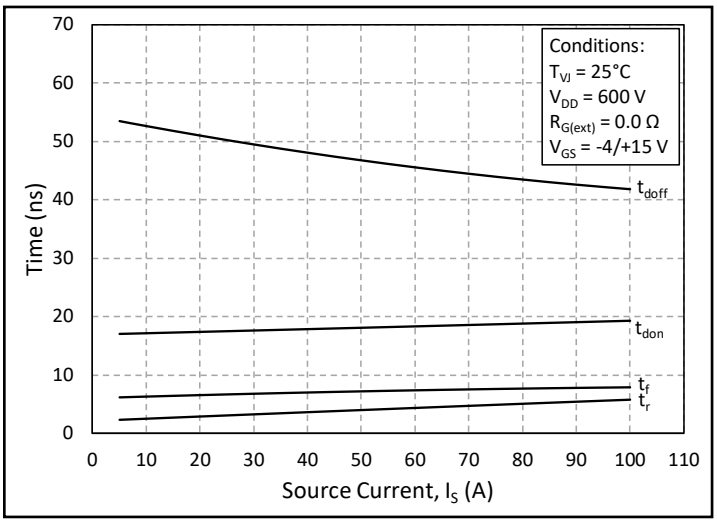

Figure 24. Timing vs. Source Current

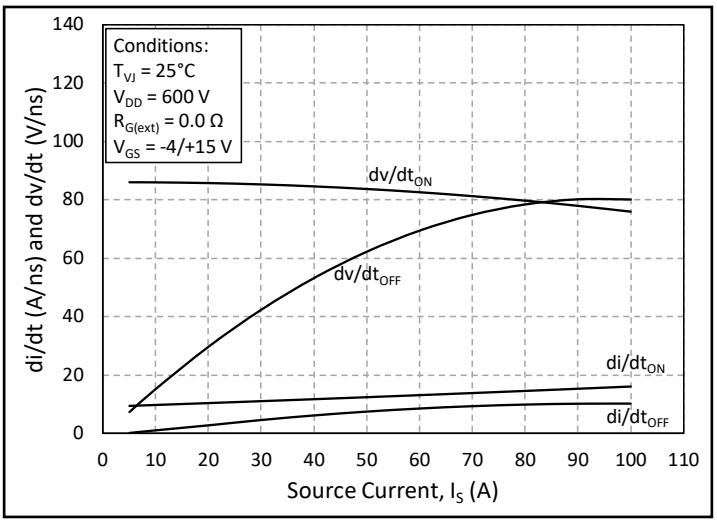

Figure 25. dv/dt and di/dt vs. Source Current

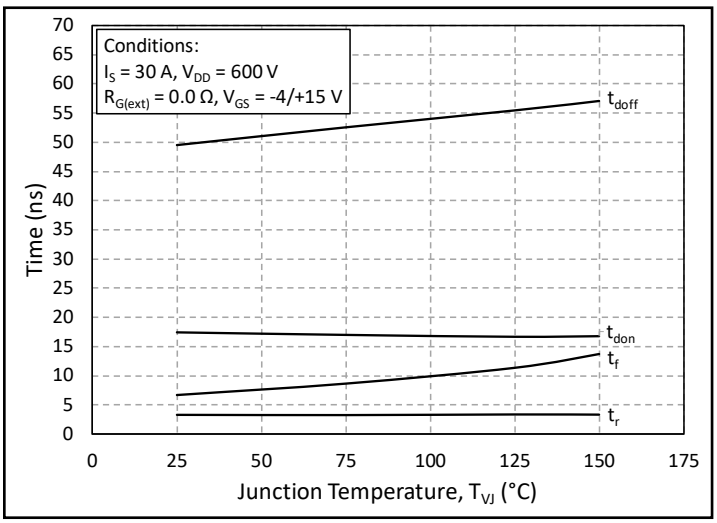

Figure 26. Timing vs. Junction Temperature

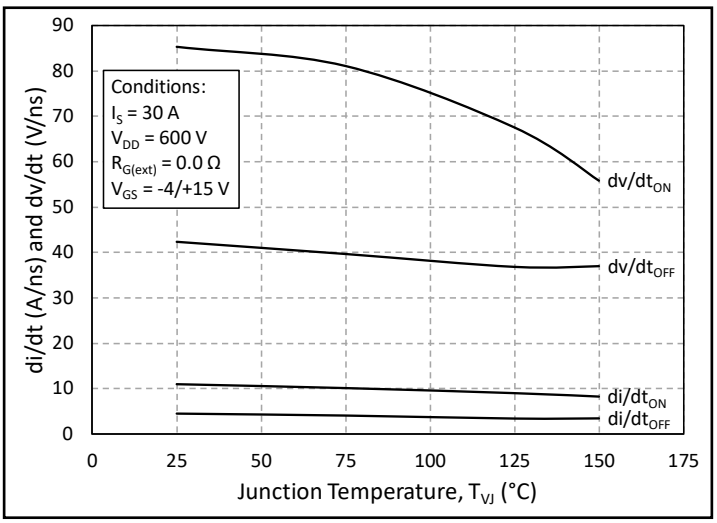

Figure 27. dv/dt and di/dt vs. Junction Temperature

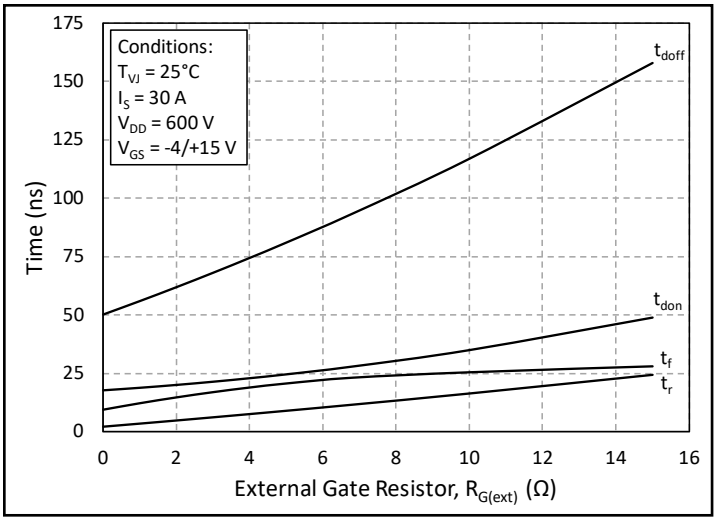

Figure 28. Timing vs. External Gate Resistance

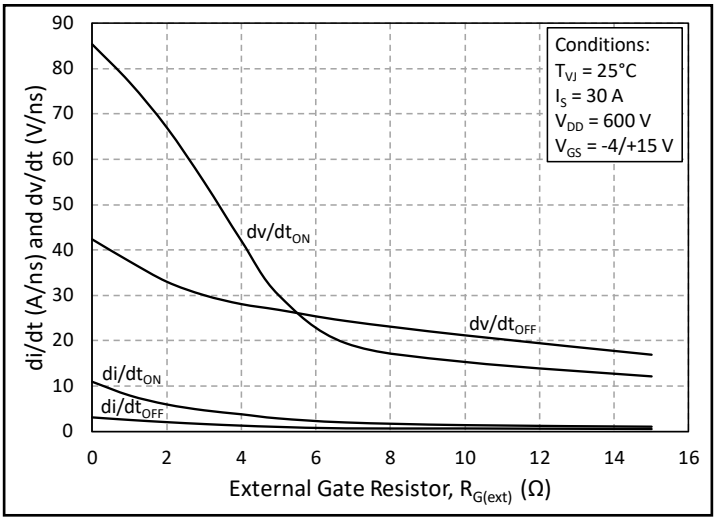

Figure 29. dv/dt and di/dt vs. External Gate Resistance

Definitions

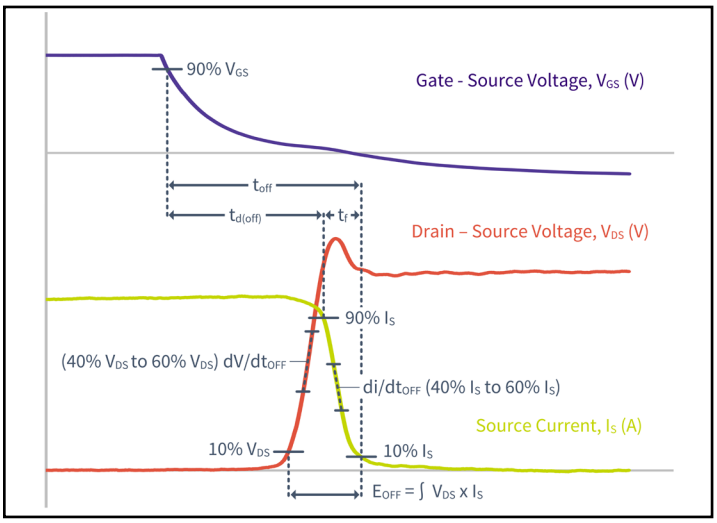

Figure 30. Turn-off Transient Definitions

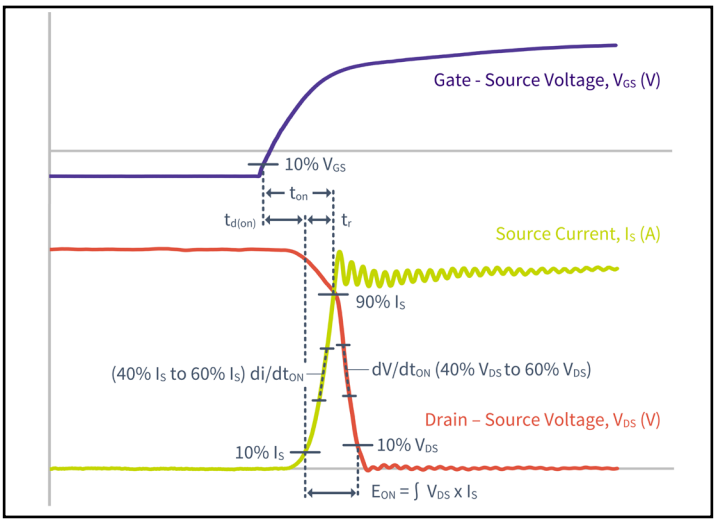

Figure 31. Turn-on Transient Definitions

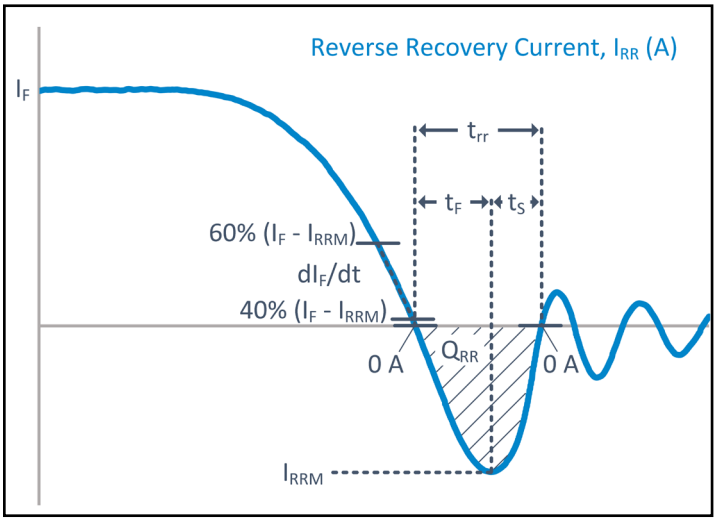

Figure 32. Reverse Recovery Definitions

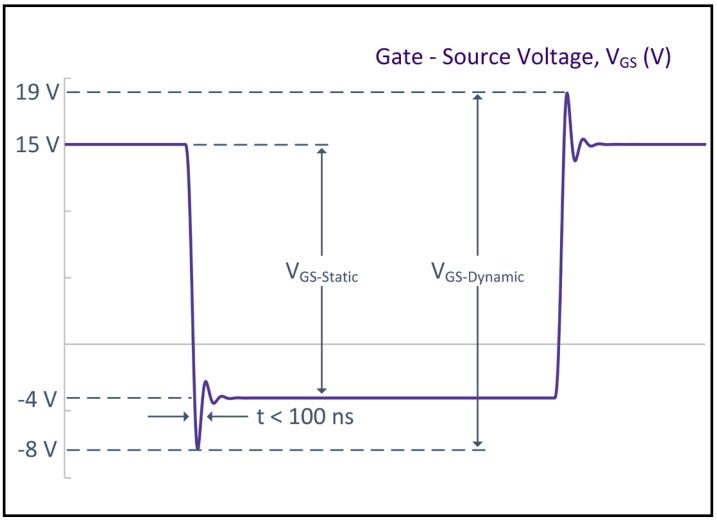

Figure 33. V_{GS} Transient Definitions

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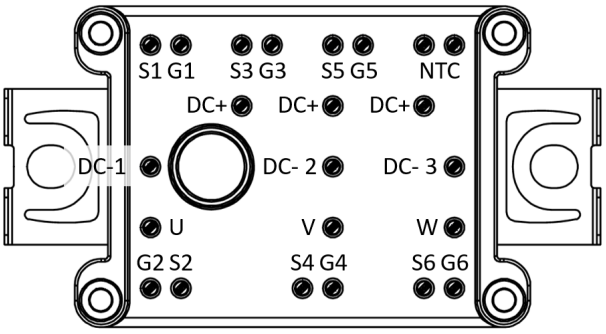
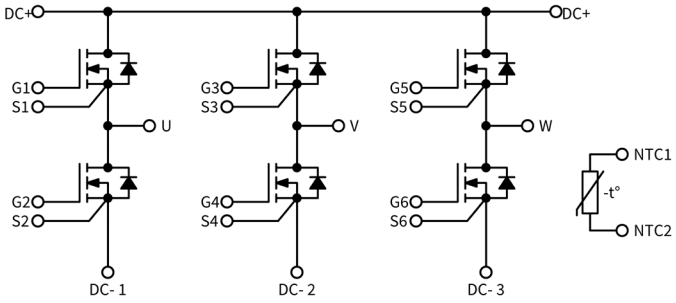
Schematic and Pin Out





Package Dimension (mm)